

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,833	CHANG ET AL.	
Examiner	Art Unit	
Jonnifor P. Sadula	1756	

SEARCHED					
Subclass	Date	Examiner			
270.1. 270.11, 270.12, 270.13	3/30/2005	JRS			
		1			
		17 - 30			
	270.1. 270.11, 270.12,	Subclass Date  270.1. 270.11, 270.12, 3/30/2005			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH I (INCLUDING SEAR		)
	DATE	EXMR
East Search (see attached)	3/30/2005	JRS
ODP Search	3/30/2005	JRS